

## PRELIMINARY 6180 HARDWARE PERFORMANCE MEASUREMENTS

by D. K. Gifford

## I. Introduction

From software measurements made last Spring it was clear that the Honeywell 6180 was not performing as expected. Professor Saltzer's measurements reported in Request for Comments Number 19 indicated that 6180 hardware performance was degraded from first estimates.

To provide more insight into the performance of the 6180 I conducted hardware measurements on the MIT Information Processing Center's Multics System during November 1973. Test points of interest were identified in advance by Honeywell and MAC personnel, and sampled while operating under normal service conditions.

A six digit counter was used to gather the data. For the measurements that involved taking ratios of two things (eg indirect cycles to instructions) the higher frequency test point was used as an external clock in a digital frequency meter. In this manner ~~ratio measurements~~ were relatively easy to make.

## II. Analysis of Results

Careful analysis of the results reported here are to the subject of a later report. I would appreciate comments on the possible significance that could be attached to these measurements.

## III. Analysis of Error

As all of these measurements were done under uncontrolled conditions, the results must be suspect. Memory interference and atypical instruction mixes could prejudice the results reported to a significant extent.

Identifying test points proved to be extremely difficult in some cases. For example, the 6180 does not have one point that goes high on every instruction execution; such a point is not necessary to make the processor functional. Thus, approximations were made, and in some cases, the hardware was modified to provide closer estimates.

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#### IV. Further Work

Comparisons of a 6180 running in 6080 mode vs. a 6080 under controlled conditions should be extremely interesting. Measurements of this kind are planned, along with more extensive measurements of the 6180 to pin point difficulties. Suggestions for interesting points to examine are welcome.

#### V. Configuration Notes

All tests were made using the non bootload highest port priority processor in a dual processor, 3 SCU, 384K, 2MW bulk store system running Multics version 21-2 unless otherwise noted. SCU C is the high order SCU containing pagable core. SCU A contains the perm wired segments. The bulk store has a higher port priority than either processor. Under system 21-2 the idle process consisted of a DIS instruction.

The GCOS measurements were made on the non bootload highest port priority processor in a dual 6080 256K system at the Ford Motor Company, in Dearborn, Michigan.

The GCOS system was running with two fully interlaced SCU's while the MIT system does not run with port interlace.

#### VI. Acknowledgements

John Zona of Honeywell provided invaluable assistance in locating the test points and making the measurements. The MIT Information Processing Center was very cooperative throughout the tests. Helpful discussions were provided by Dr. David Clark, Professors J. Saltzer and M. Schroeder, and Steve Webber of Honeywell.

November 6, 1973

15:38

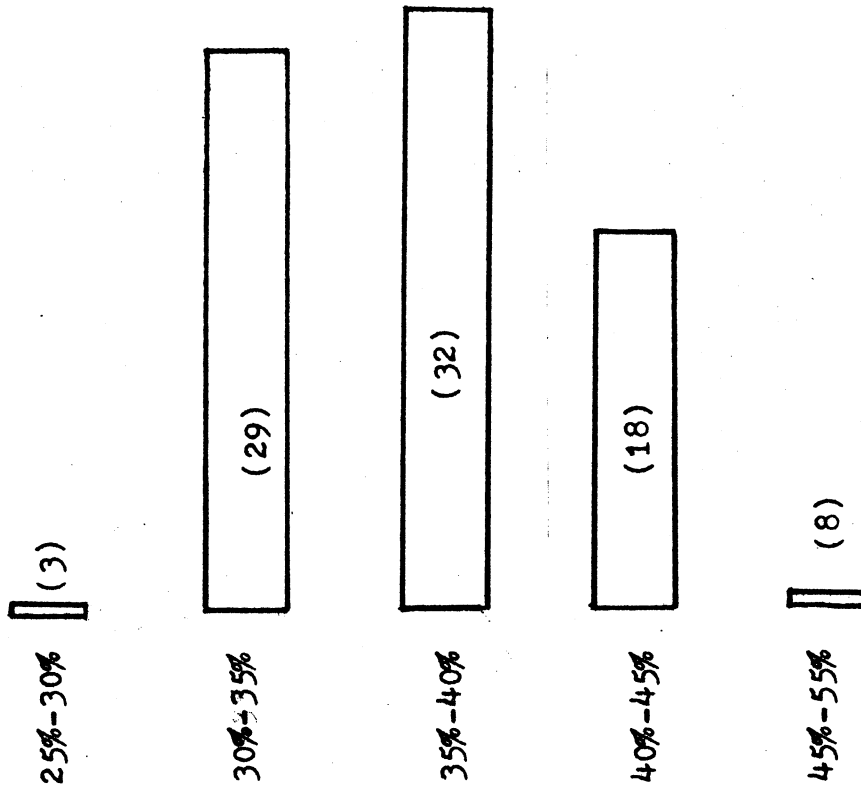
30 Load Units

Measurement: store instructions / instructions

Intent: Measure percentage of instructions that modify a storage location

Mean: 37.6%

Test Points: Store instructions: PM-6R03  
Instructions: CV-2B09



( ) indicates number of samples observed. Each sample was averaged over  $10^6$  instructions.

November 20, 1973

16:04-16:12

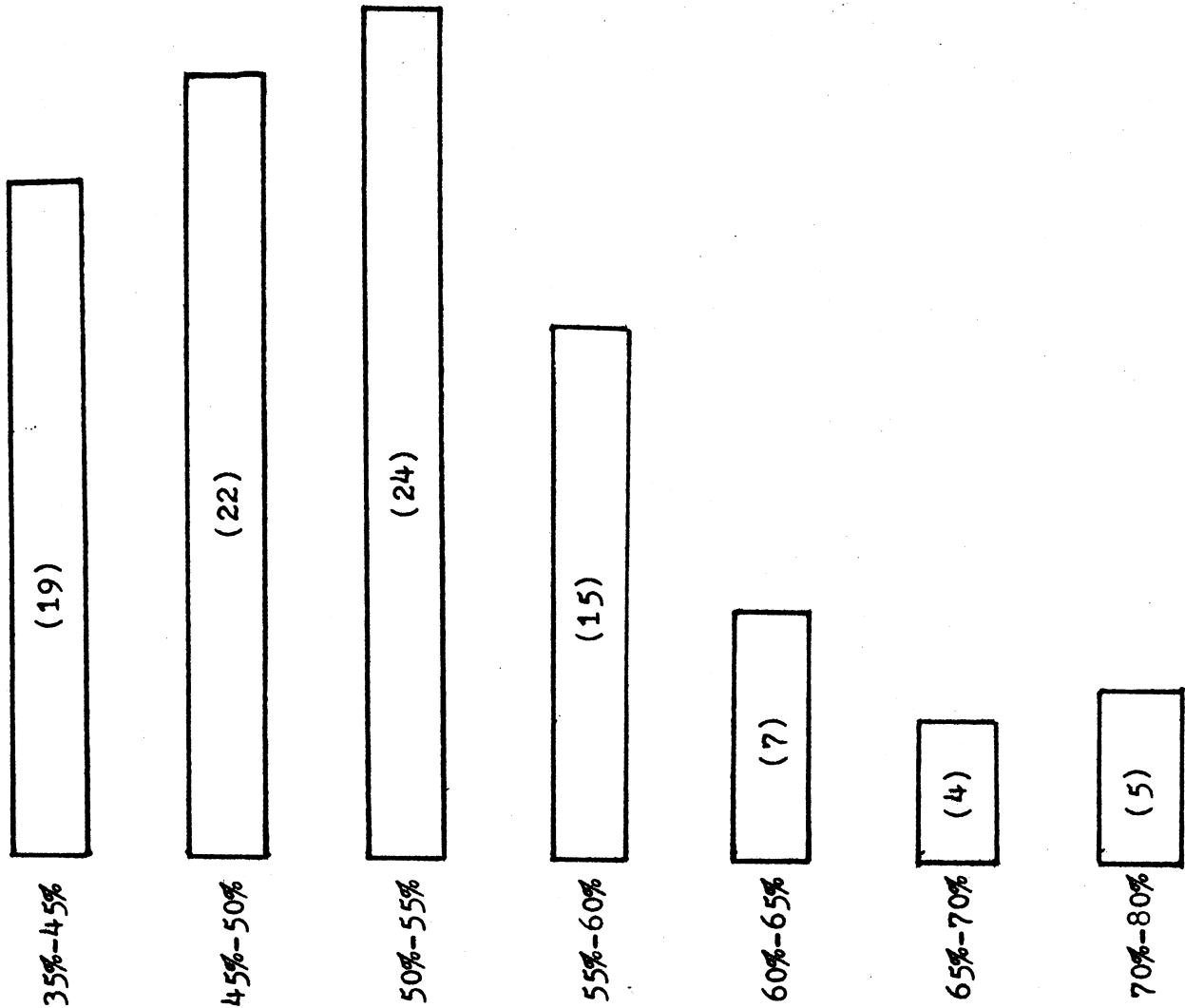
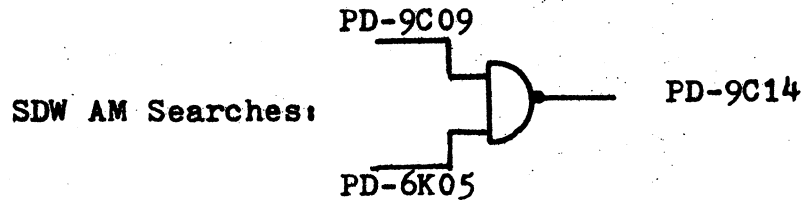
65 Load Units

Measurement: PTW AM Searches / SDW AM Searches

Intent: Measure percentage of time Multics runs in paged memory

Mean: 52.5%

Test Points: PTW AM Searches: PD-3L12



SPG "user time" approx 47%

( ) Number of samples observed at indicated range. Each sample was averaged over 10<sup>6</sup> SDW AM searches.

November 8, 1973

13:15-13:20

45 Load Units

Measurement: Instructions executed / one second

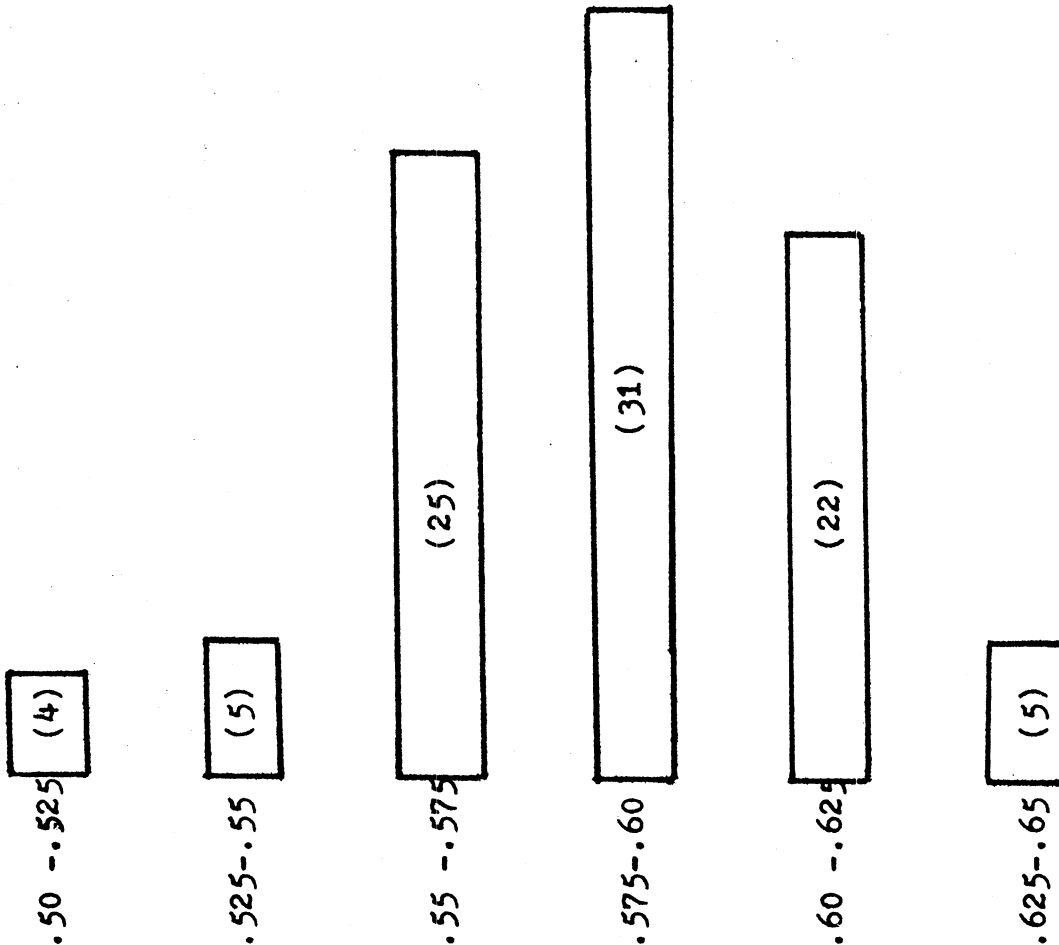
Intent: Find speed of 6180 processor

Mean: .582 Million Instructions per Second (MIPS)

*~ 1.7 μsec/instr.*

Test Point: Instructions: CV-2B09

Note: DIS time was not factored out. SPG indicated that the processor was in DIS about one percent of the time.



( ) indicates number of samples observed within indicated range. Each sample was for one second.

November 6, 1973

14:09-14:30

50 Load Units

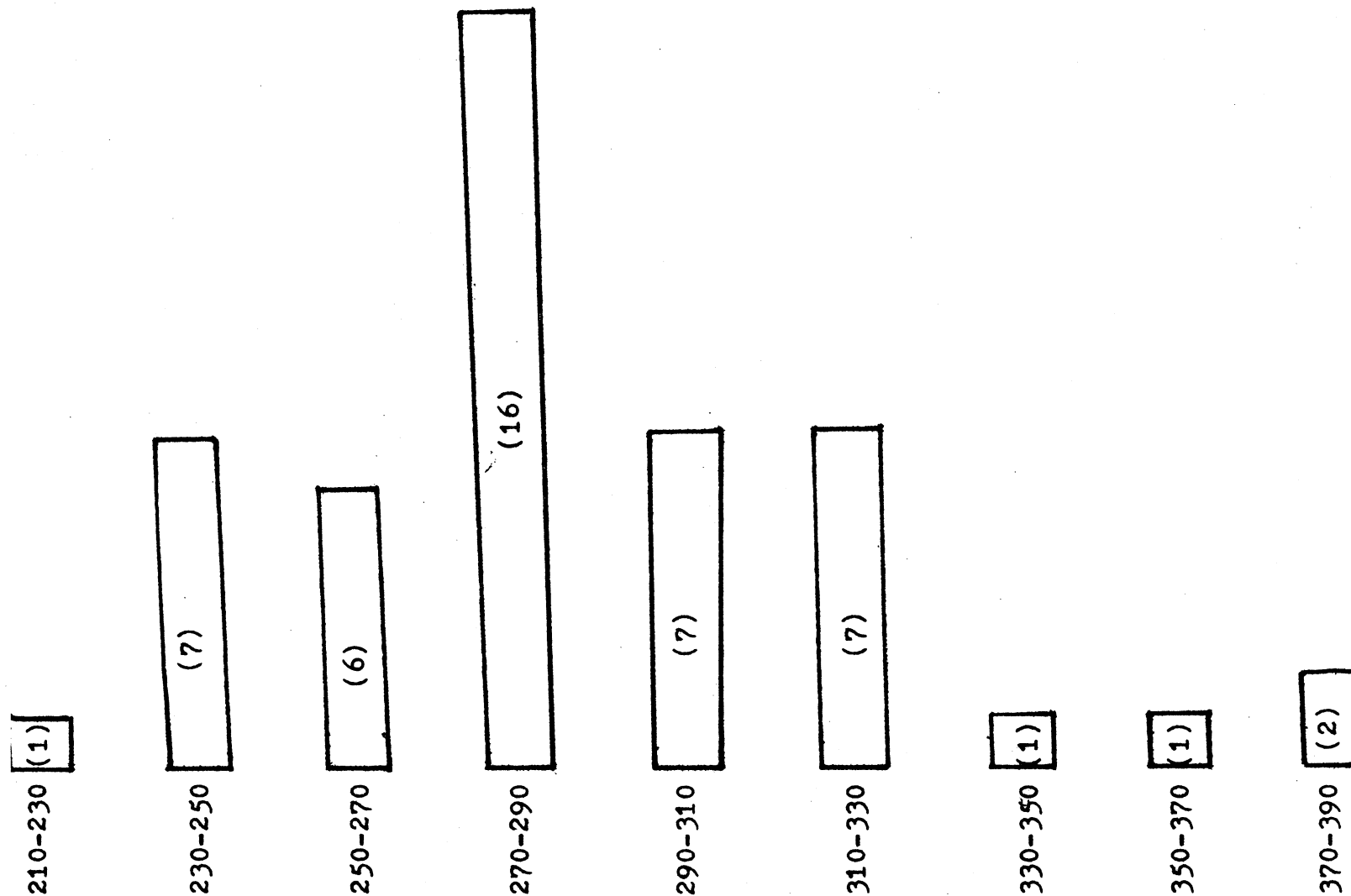
Measurement: RTCD Instructions / Instructions

Intent: Approximate the average number of instructions executed per procedure call

Mean: 281 instructions / RTCD instruction

Test Points: RTCD Instructions: PX-OH05  
Instructions: CV-2B09

Note: PX-OH05 is a very shaky test point



Instructions / RTCD Instruction

( ) Number of samples observed within indicated range.  
Each sample averaged over 10<sup>7</sup> instructions.

November 27, 1973      9:30-9:35      63 Users

Measurement: Instructions / one second

Intent: Measure speed of 6080 running GCOS and compare it with  
a 6180 running Multics → *conclusion?*

Mean: .929 Million Instructions per Second (MIPS)

Test Point: Instructions: CV-2B09

Note: DIS time was not factored out. Meters in GCOS indicated the  
processor was in DIS about five percent of the time.

Sample Size: 96      Sample Averaged Over: 1 second

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November 6, 1973      11:23      50 Load Units      *Test Nov. 8?*

Measurement: Instructions / one second

Intent: Find speed of 6180 processor

Mean: .554 Million Instructions per Second (MIPS)      *.582*

Test Point: Instructions: GV-2B09

Note: DIS time was not factored out. SPG indicated that the processor  
was in DIS about five percent of the time..

Sample size: 96      Sample Averaged over: 1 second

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November 20, 1973      15:50-16:00      60 Load Units

Measurement: SDW AM "found" / SDW AM Searches

Intent: Find effectiveness of 6180 SDW AM

Mean: 98.95% hit

Test Point: SDW AM "found": PD-4G12  
SDW AM searches: PD-9C14 (see page 4)

Sample Size: 96      Sample Averaged Over: 10<sup>6</sup> SDW AM searches

November 8, 1973          13:41-13:54          49 Load Units

Measurement: PTW AM "found" / PTW AM Searches

Intent: Find effectiveness of 6180 PTW AM

Mean: 98.67% hit

Test Points: PTW AM "found" : PD-4H12  
PTW AM Searches: PD-3L12

Sample Size: 96                  Each Sample Averaged over:  $10^6$  PTW AM Searches

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November 8, 1973          15:14                  62 Load Units

Measurement: Memory cycles SCU C / Memory cycles SCU A

Intent: Approximate effect of interlacing memories 2

Mean: .401

Test Points: Memory cycles SCU C: TP-19 SCU C  
Memory cycles SCU A: TP-19 SCU A

Sample Size: 48                  Each Sample Averaged over:  $10^6$  SCU A Mem Cycles

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November 8, 1973          14:42-14:47          59 Load Units

Measurement: Bulk store memory cycles SCU C / CPU B Memory cycles SCU C

Intent: See how much of a load the bulk store places on an SCU in terms of a processor

Mean: .28

Test Points: Bulk store memory cycles SCU C: SCU C TP-12  
CPU B memory cycles SCU C:                  SCU C TP-16

Sample Size: 24                  Each Sample Averaged over:  $10^6$  SCU B Mem Cycles



November 8, 1973

14:52-14:56

61 Load Units

Measurement: Bulk store memory cycles SCU C / SCU C Memory cycles

Intent: Find the load the bulk store places on SCU C

Mean: .22

Test Points: Bulk store memory cycles SCU C; SCU C TP-12  
SCU C Memory cycles : SCU C TP-19

Sample Size: 24 Sample Averaged Over:  $10^6$  SCU C Mem Cycles

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November 8, 1973

15:00-

60 Load Units

Measurement: IOM memory cycles SCU C / SCU C memory cycles

Intent: Find the load the IOM presents to SCU C

Mean: .034

Test Points: IOM memory cycles SCU C; SCU C TP-10  
SCU C memory cycles : SCU C TP-19

Sample Size: 24 Sample Averaged Over:  $10^6$  SCU C Mem Cycles

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November 8, 1973

15:07

62 Load Units

Measurement: SCU C memory cycles / one second Sample Size: 48

Intent: Find absolute loading of SCU C

Mean: .273 Million Memory Cycles per Second (MMCPs)

Test Point: SCU C Memory cycles: TP-19 SCU C

*mem. cycles/instruction*  
Sample Av. Over: 1 sec

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November 8, 1973

13:30

40 Load Units

Measurement: ITS indirects / indirects

Intent: Find percentage of indirects that are ITS indirects

Mean: .933

Test Points: ITS indirects: FX-WH16  
indirects : PX-OL07

Sample Size: 48

Sample Averaged Over:  $10^6$  indirects

November 6, 1973                      11:52                      50 Load Units

Measurement: ITS indirects / instructions

Intent: Find frequency of ITS indirects on instructions

Mean: .102

Test Points: ITS indirects: PX\*WH16  
instructions : CV-2B09

Sample Size: 96                                      Sample Averaged Over:  $10^6$  instructions

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November 6, 1973                      11:30                      51 Load Units

Measurement: indirects / instructions

Intent: Find frequency of indirects on instructions

Mean: .112

Test Points: indirects: PX-0L07  
instructions: CV-2B09

Sample Size: 96                                      Sample Averaged Over:  $10^6$  instructions